Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
08/252,384	MCDANIEL ET AL.	
Examiner	Art Unit	
Yong D. Pak	1652	

	SEARCHED		
Class	Subclass	Date	Examiner
435	195	4/20/2005	YP
435	252.3	4/20/2005	YP
435	320.1	4/20/2005	YP
435	69.1	4/20/2005	YP
435	71.1	4/20/2005	YP
435	4	4/20/2005	YP
435	6	4/20/2005	YP
435	440	4/20/2005	YP
536	23.2	4/20/2005	YP
536	23.7	4/20/2005	YP
435	320	4/20/2005	YP

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
<u> </u>			

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
stic: seq id no:1 and 2	4/20/2005	YP
inventor search	4/20/2005	ΥP
stn/east: see search history	4/20/2005	ΥP
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